DEVICE SPECIFICATIONS

NI 6232

M Series Data Acquisition: 16-Bit, 250 kS/s, 16 AI, 2 AO, 24 DIO Sourcing, Voltage Input/Output Bank Isolation

The following specifications are typical at 25 °C, unless otherwise noted. For more information about the NI 6232, refer to the NI 6232/6233 User Manual available from *ni.com/manuals*.

Analog Input

| Number of channels | 8 differential or 16 single ended |
|---|--|
| Channel type | Voltage input |
| Ground reference | AI GND |
| ADC resolution | 16 bits |
| DNL | No missing codes guaranteed |
| INL | Refer to the AI Absolute Accuracy section |
| Sample rate | |
| Maximum | 250 kS/s |
| Minimum | No minimum |
| Timing accuracy | 50 ppm of sample rate |
| Timing resolution | 50 ns |
| Input coupling | DC |
| Input range | ±0.2 V, ±1 V, ±5 V, ±10 V |
| Maximum working voltage for analog inputs | Refer to the Maximum Working Voltage section |
| CMRR (DC to 60 Hz) | 95 dB (with respect to AI GND) |
| Input impedance | |
| Device on | |
| AI+ to AI GND | $>$ 10 G Ω in parallel with 100 pF |
| AI- to AI GND | >10 GΩ in parallel with 100 pF |



| - | | | | cc |
|------|-----|-----|---|----|
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| | | | | |

| AI+ to AI GND | 820 Ω | |
|---|--|--|
| AI- to AI GND | 820 Ω | |
| Input bias current | ±100 pA | |
| Crosstalk (at 100 kHz) | | |
| Adjacent channels | -75 dB | |
| Non-adjacent channels | -90 dB | |
| Small signal bandwidth (-3 dB) | 700 kHz | |
| Input FIFO size | 4,095 samples | |
| Scan list memory | 4,095 entries | |
| Data transfers | DMA (scatter-gather), interrupts, programmed I/O | |
| Overvoltage protection (AI <07> with respection | ect to AI GND) | |
| Device on | ±25 V for up to two AI pins | |
| Device off | ±15 V for up to two AI pins | |
| Input current during overvoltage condition | ±20 mA maximum/AI pin | |

Settling Time for Multichannel Measurements

| Accuracy, full-scale step, all ranges | |
|---------------------------------------|-----------------------|
| ±90 ppm of step (±6 LSB) | 4 μs convert interval |
| ±30 ppm of step (±2 LSB) | 5 μs convert interval |
| ±15 ppm of step (±1 LSB) | 7 μs convert interval |

Typical Performance Graphs

Figure 1. Settling Error versus Time for Different Source Impedances

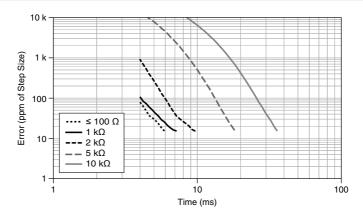
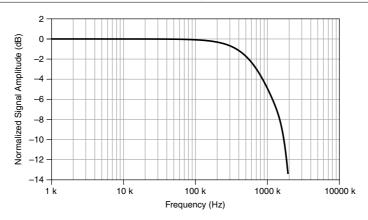


Figure 2. Al Small Signal Bandwidth



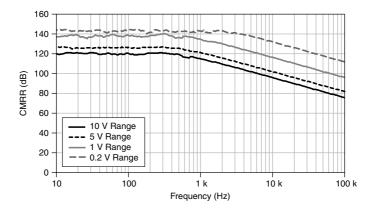
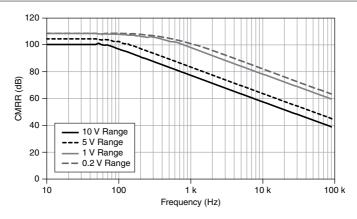


Figure 4. AI CMRR to AI GND



Al Absolute Accuracy



Note Accuracies listed are valid for up to one year from the device external calibration.

Table 1. Al Absolute Accuracy

| Nominal Range Positive Full Scale | Nominal Range Negative Full Scale | Residual Gain Error (ppm of Reading) | Residual Offset Error (ppm of Range) | Offset Tempco (ppm of Range/°C) | Random Noise, σ (μVrms) | Absolute Accuracy at Full Scale (µV) | Sensitivity (μV) |
|---|---|--|--|--|-------------------------------|--------------------------------------|---------------------|
| 10 | -10 | 75 | 20 | 57 | 244 | 3,100 | 97.6 |
| 5 | -5 | 85 | 20 | 60 | 122 | 1,620 | 48.8 |
| 1 | -1 | 95 | 25 | 79 | 30 | 360 | 12.0 |
| 0.2 | -0.2 | 135 | 80 | 175 | 13 | 112 | 5.2 |



Note Sensitivity is the smallest voltage change that can be detected. It is a function of noise.

| Gain tempco | 25 ppm/°C |
|------------------|-----------------|
| Reference tempco | 5 ppm/°C |
| INL error | 76 ppm of range |

Al Absolute Accuracy Equation

```
AbsoluteAccuracy = Reading \cdot (GainError) + Range \cdot (OffsetError) + NoiseUncertainty
     GainError = ResidualAIGainError + GainTempco \cdot (TempChangeFromLastInternalCal)
     + ReferenceTempco · (TempChangeFromLastExternalCal)
     OffsetError = ResidualAIOffsetError + OffsetTempco
     (TempChangeFromLastInternalCal) + INLError
     NoiseUncertainty = \frac{\text{Random Noise} \cdot 3}{\sqrt{100}} for a coverage factor of 3 \sigma and averaging
     100 points.
```

Al Absolute Accuracy Example

Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

- TempChangeFromLastExternalCal = 10 °C
- TempChangeFromLastInternalCal = 1 °C
- number of readings = 100
- CoverageFactor = 3σ

For example, on the 10 V range, the absolute accuracy at full scale is as follows:

GainError = 75 ppm + 25 ppm
$$\cdot$$
 1 + 5 ppm \cdot 10 = 150 ppm
OffsetError = 20 ppm + 57 ppm \cdot 1 + 76 ppm = 153 ppm

NoiseUncertainty =
$$\frac{244 \mu V \cdot 3}{\sqrt{100}}$$
 = 73 μV

AbsoluteAccuracy = $10 \text{ V} \cdot (GainError) + 10 \text{ V} \cdot (OffsetError) + NoiseUncertainty =$ $3,100 \mu V$

Analog Output

| 2 Voltage output |
|--|
| * |
| |
| AO GND |
| 16 bits |
| ±1 LSB |
| 16 bit guaranteed |
| |
| 500 kS/s |
| 450 kS/s per channel |
| 50 ppm of sample rate |
| 50 ns |
| ±10 V |
| DC |
| 0.4 Ω |
| ±5 mA |
| ±25 V |
| 10 mA |
| ±20 mV |
| 0.25 V peak for 1 ms |
| ±100 mV peak for 350 ms |
| 8,191 samples shared among channels used |
| DMA (scatter-gather), interrupts, programmed I/O |
| Non-periodic waveform, periodic waveform regeneration mode from onboard FIFO, periodic waveform regeneration from host buffer including dynamic update |
| |

| Settling time, full-scale step, 15 ppm (1 LSB) | 6 μs |
|---|---------|
| Slew rate | 15 V/μs |
| Glitch energy | |
| Magnitude | 100 mV |
| Duration | 3 μs |

AO Absolute Accuracy

Absolute accuracy at full-scale numbers is valid immediately following internal calibration and assumes the device is operating within 10 °C of the last external calibration.



Note Accuracies listed are valid for up to one year from the device external calibration.

Table 2. AO Absolute Accuracy

| Nominal Range Positive Full Scale | Nominal Range Negative Full Scale | Residual Gain Error (ppm of Reading) | Gain Tempco (ppm/°C) | Residual Offset Error (ppm of Range) | Offset Tempco (ppm of Range/°C) | Absolute Accuracy at Full Scale (µV) |
|--|--|---|----------------------------|---|--|--------------------------------------|
| 10 | -10 | 90 | 10 | 40 | 5 | 3,230 |

| Reference tempco | 5 ppm/°C |
|------------------|------------------|
| INL error | 128 ppm of range |

AO Absolute Accuracy Equation

 $AbsoluteAccuracy = OutputValue \cdot (GainError) + Range \cdot (OffsetError)$

 $GainError = ResidualGainError + GainTempco \cdot (TempChangeFromLastInternalCal) +$

ReferenceTempco · (TempChangeFromLastExternalCal)

OffsetError = ResidualOffsetError + AOOffsetTempco

(TempChangeFromLastInternalCal) + INLError

Digital I/O/PFI

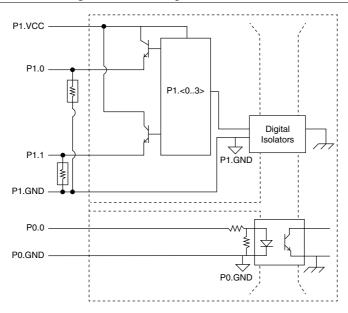
Static Characteristics

| Number of channels | 10 total |
|--------------------------|----------------------|
| Number of input channels | 6 (PFI <05>/P0.<05>) |

| A (DEL 46 0) /D1 40 2) | |
|---|--|
| 4 (PFI <69>/P1.<03>) | |
| Fixed, lines are unidirectional | |
| ality | |
| Static digital input, timing input | |
| Static digital output, timing output | |
| Many AI, AO, counter timing signals | |
| 125 ns, 6.425 μ s, 2.56 ms, disable; high and low transitions; selectable per input | |
| | |
| 6 | |
| P0.GND | |
| 0 V to 30 V | |
| 0.5 μs | |
| 0 V to 4 V | |
| 10 V to 30 V | |
| $3.3~\mathrm{k}\Omega$ | |
| 7 mA at 24 V input, 2.5 mA at 8 V input | |
| 9 mA | |
| | |
| 150 ns, typical | |
| 100 ns, typical | |
| | |
| 4 | |
| P1.GND | |
| DO source | |
| | |

The following figure shows PO.<0..5> and PI.<0..3> on the NI 6232 device.

Figure 5. NI 6232 Digital I/O Connections



| Maximum external supply voltage (P1.VCC) | 30 V |
|---|---|
| On state saturation voltage | 1.6 V maximum at 350 mA |
| Off state leakage | 50 μΑ |
| Maximum current | 100 mA for each line for simultaneous usage, 350 mA for single line usage |
| Minimum pulse width for timing signal (source output) | 5 μs |
| Propagation delay (source output) | |
| Open to close | 0.45 μs |
| Close to open | 2.15 μs |

General-Purpose Counters/Timers

| Number of counter/timers | 2 |
|--------------------------|--|
| Resolution | 32 bits |
| Counter measurements | Edge counting, pulse, semi-period, period, two-edge separation |

| Position measurements | X1, X2, X4 quadrature encoding with Channel Z reloading; two-pulse encoding |
|-------------------------------|--|
| Output applications | Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling |
| Internal base clocks | 80 MHz, 20 MHz, 0.1 MHz |
| External base clock frequency | 0 MHz to 20 MHz |
| Base clock accuracy | 50 ppm |
| Inputs | Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down |
| Routing options for inputs | Any input PFI, RTSI, PXI_TRIG, PXI_STAR, many internal signals |
| FIFO | 2 samples |
| Data transfers | Dedicated scatter-gather DMA controller for each counter/timer; interrupts; programmed I/O |

Frequency Generator

| Number of channels | 1 |
|---------------------|-----------------|
| Base clocks | 10 MHz, 100 kHz |
| Divisors | 1 to 16 |
| Base clock accuracy | 50 ppm |

Output can be available on any output PFI or RTSI terminal.

Phase-Locked Loop (PLL)

| Number of PLLs | 1 |
|------------------|--|
| Reference signal | PXI_STAR, PXI_CLK10, RTSI <07> |
| Output of PLL | 80 MHz Timebase; other signals derived from 80 MHz Timebase including 20 MHz and 100 kHz Timebases |

External Digital Triggers

| Source | Any PFI, RTSI, PXI_TRIG, PXI_STAR |
|----------|--------------------------------------|
| Polarity | Software-selectable for most signals |

| Analog input function | Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase |
|------------------------|---|
| Analog output function | Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase |
| Counter/timer function | Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down |

Device-to-Device Trigger Bus

| PCI | RTSI <07>1 |
|--------------------------|--|
| PXI | PXI_TRIG <07>, PXI_STAR |
| Output selections | 10 MHz Reference Clock, frequency generator output, many internal signals |
| Debounce filter settings | 125 ns, 6.425 μs, 2.56 ms, disable; high and low transitions; selectable per input |

Bus Interface

| PCI/PXI | 3.3 V or 5 V signal environment |
|---|--|
| The PXI device can be installed in PXI slots or | r PXI Express hybrid slots. |
| DMA channels | 4, analog input, analog output, counter/timer 0, counter/timer 1 |

Power Requirements

| Current draw from bus during no-load condition | | |
|--|--------|--|
| +5 V 0.7 A | | |
| +12 V | 20 mA | |
| Current draw from bus during AI and AO overvoltage condition | | |
| +5 V | 0.95 A | |
| +12 V | 20 mA | |

¹ In other sections of this document, RTSI refers to RTSI <0..7> for the PCI devices or PXI_TRIG <0..7> for PXI devices.

Physical Characteristics

| Dimensions | |
|---------------------------|--------------------------------------|
| PCI printed circuit board | 9.7 cm × 15.5 cm (3.8 in. × 6.1 in.) |
| PXI printed circuit board | Standard 3U PXI |
| Weight | |
| PCI | 103 g (3.6 oz) |
| PXI | 142 g (5.0 oz) |
| I/O connector | 37-pin D-SUB |

Calibration

| Recommended warm-up time | 15 minutes |
|--------------------------|------------|
| Calibration interval | 1 year |

Maximum Working Voltage

Maximum working voltage refers to the signal voltage plus the common-mode voltage.

| ≤30 Vrms/60 VDC Measurement Category I |
|--|
| ≤840 Vrms/1,200 VDC, verified by a 5 s dielectric withstand test |
| |
| ≤30 Vrms/60 VDC Measurement Category I |
| ≤1,400 Vrms/1,950 VDC, verified by a 5 s dielectric withstand test |
| ≤11 V, Measurement Category I |
| ≤30 V, Measurement Category I |
| |

Measurement Category I is for measurements performed on circuits not directly connected to the electrical distribution system referred to as MAINS voltage. MAINS is a hazardous live electrical supply system that powers equipment. This category is for measurements of voltages

 $[\]begin{array}{ll} ^{2} & \text{In the figure, } |V_{a}-V_{h}|,\, |V_{c}-V_{h}|,\, \text{and } |V_{e}-V_{h}|. \\ ^{3} & \text{In the figure, } |V_{a}-V_{g}|,\, |V_{c}-V_{g}|,\, \text{and } |V_{e}-V_{g}|. \end{array}$

from specially protected secondary circuits. Such voltage measurements include signal levels, special equipment, limited-energy parts of equipment, circuits powered by regulated lowvoltage sources, and electronics.



Caution This device is rated for Measurement Category I and the voltage across the isolation barrier is limited to no greater than 30 Vrms/60 VDC/42.4 V_{nk} continuous. These test and measurement circuits are not intended for direct connection to the MAINS building installations of Measurement Categories CAT II, CAT III, or CAT IV.

The following figure illustrates the maximum working voltage specifications.

PXI/PCI-Bus − Al *x*/AO *x* - AI GND/AO GND - PFI <0..5> - PFI <6..9>

Figure 6. NI 6232 Maximum Working Voltage

Environmental

| Operating temperature | 0 °C to 55 °C |
|-----------------------|---------------------------------|
| Operating humidity | 10% RH to 90% RH, noncondensing |

| Storage temperature | -40 °C to 70 °C |
|---------------------|--------------------------------|
| Storage humidity | 5% RH to 95% RH, noncondensing |
| Maximum altitude | 2,000 m |
| Pollution Degree | 2 |

Indoor use only.

Shock and Vibration (PXI Only)

| Operational shock | 30 g peak, half-sine, 11 ms pulse (Tested in accordance with IEC 60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.) |
|-------------------|---|
| Random vibration | |
| Operating | 5 Hz to 500 Hz, $0.3 g_{rms}$ |
| Nonoperating | 5 Hz to 500 Hz, 2.4 g _{rms} (Tested in accordance with IEC 60068-2-64. Nonoperating test profile exceeds the requirements of MIL-PRF-28800F, Class 3.) |

Safety

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA 61010-1



Note For UL and other safety certifications, refer to the product label or the *Online Product Certification* section.

Electromagnetic Compatibility

This product meets the requirements of the following EMC standards for electrical equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Basic immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- EN 55022 (CISPR 22): Class A emissions
- EN 55024 (CISPR 24): Immunity
- AS/NZS CISPR 11: Group 1, Class A emissions
- AS/NZS CISPR 22: Class A emissions

- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions



Note In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia and New Zealand (per CISPR 11) Class A equipment is intended for use only in heavy-industrial locations.



Note Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency energy for the treatment of material or inspection/analysis purposes.



Note For EMC declarations and certifications, and additional information, refer to the Online Product Certification section.

CE Compliance (€

This product meets the essential requirements of applicable European Directives, as follows:

- 2014/35/EU; Low-Voltage Directive (safety)
- 2014/30/EU; Electromagnetic Compatibility Directive (EMC)
- 2011/65/EU; Restriction of Hazardous Substances (RoHS)

Online Product Certification

Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for this product, visit ni.com/ certification, search by model number or product line, and click the appropriate link in the Certification column

Environmental Management

NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the Minimize Our Environmental Impact web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document

Waste Electrical and Electronic Equipment (WEEE)

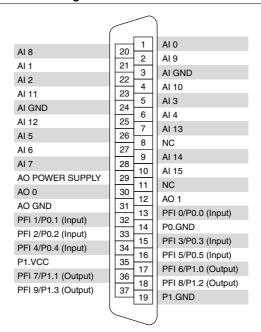
EU Customers At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit *ni.com/environment/weee*.

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Device Pinout

Figure 7. NI PCI/PXI-6232



NC = No Connect

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